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p-Type CuCrO_2 particulate films as the hole transporting layer for $\text{CH}_3\text{NH}_3\text{PbI}_3$ perovskite solar cells†

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CuCrO_2 with a crystal structure of delafossite is a promising material as a transparent conducting oxide. It shows unique properties, for example, wide band gap, good chemical stability, and p-type carrier transporting character. The oxide layers with delafossite structure have been suggested as hole transporting materials for organic–inorganic $\text{CH}_3\text{NH}_3\text{PbI}_3$ perovskite solar cells. In this study, we fabricated inverted (p–i–n) type planar perovskite solar cells with CuCrO_2 nanoparticles synthesized by the hydrothermal method and their films were formed by spin-coating without any further heat treatment. The champion device gave a 13.1% of power conversion efficiency and CuCrO_2 based devices show improved stability in ambient air compared with the standard PEDOT:PSS based perovskite solar cells.

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Introduction

Semiconducting thin films of organo-metal lead halides as light absorbing layers in photovoltaic cells, known as perovskite solar cells (PSCs), draw much attention.^{1–5} The PSCs show outstanding high power conversion efficiencies (PCEs) from 3.8% to a certified value of 22.7% in a normal n–i–p structure.⁶ The surprising increase of PCE in PSCs originates from the superior optoelectronic properties of methylammonium lead triiodide ($\text{CH}_3\text{NH}_3\text{PbI}_3$) and its derivatives, such as large absorption coefficient, low exciton binding energy, and excellent charge transporting properties with long diffusion length.^{7–11} Moreover it is quite attractive to fabricate PSCs with high PCEs by a simple spin coating process. The most efficient PSCs in the normal n–i–p structure have adopted conducting organic materials such as 2,2',7,7'-tetrakis(*N,N'*-di-*p*-methoxyphenylamine)-9,9'-spirobifluorene (Spiro-OMeTAD) and poly(3,4-ethylenedioxythiophene):poly(styrene sulfonate) (PEDOT:PSS) as hole transporting layers (HTLs) on top of the absorbing perovskite films, and n-type TiO_2 particulate films on its blocking layers as electron transporting layers (ETLs). PSCs with planar and inverted (p–i–n) architectures have been researched as alternatives in order to suppress the hysteresis and increase their stability with over 20% of PCE.¹² Many groups have also studied PSCs based on p-type inorganic materials which are mostly stable, cheap and good electrical property, for example, NiO and NiO_x ,^{13–20} CoO_x ,^{21,22} $\text{Cu}_2\text{BaSnS}_4$,²³ CuI ,^{24,25} CuSCN ,^{26,27} CuO_x ,²⁸ Cu_2O ,^{29–31} MoO_x/WO_x ,³² V_2O_5 ,³³ and

Cu:CrO_x .³⁴ Synthesizing p-type transparent conductive oxides (TCOs) is inherently difficult due to their strong localization behaviour of holes at the valence band edge of the oxide materials. In this respect, delafossite compounds can be one of the promising materials for p-type TCO.³⁵ Inorganic delafossite compound having chemical formula as $\text{Cu}^{\text{I}}\text{M}^{\text{III}}\text{O}_2$, where trivalent M ions can be Al, Sc, Cr, Mn, Fe, Co, Ga, and Rh,³⁶ can be alternatives to conventional polymer PEDOT:PSS and Spiro-OMeTAD used as p-type HTLs. Specifically, CuCrO_2 has suitable property for p-type TCO such as high optical transparency due to its direct optical bandgap up to 3.3 eV, high hole mobility as value of $3 \times 10^{-1} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$, low valence band edge of 5.3 eV below the vacuum level which is appropriate aligned to $\text{CH}_3\text{NH}_3\text{PbI}_3$ for HTL.^{37–39} In addition, electrical property of delafossite materials can be optimized by doping M^{III} atoms, and increasing conductivity tracks a decreasing ionic radius of the M^{III} atoms, with high electrical conductivity of CuCrO_2 and Mg doped CuCrO_2 to be 1 and 220 S cm^{-1} , respectively.⁴⁰ The values are higher than those of other delafossite materials such as Mg:CuAlO_2 ($8 \times 10^{-2} \text{ S cm}^{-1}$)⁴¹ and Fe:CuGaO_2 (1 S cm^{-1}).⁴² p-Type electrical property is attributed to Cu since Cu vacancy is an intrinsic dominant as an acceptor-level defect and thus holes are dominantly existed in Cu 3d-orbital in CuCrO_2 .⁴³ In 2012, Xiung *et al.* introduced CuCrO_2 nanocrystals synthesized by hydrothermal method and applied them as a photocathode in dye sensitized solar cells (DSSCs). The valence band edge of CuCrO_2 relatively deeper than NiO was confirmed by Mott–Schottky analysis.³⁸ In 2016, Wang *et al.* reported organic photovoltaic devices (OPVs) based on ultra-small CuCrO_2 nanocrystals synthesized by a microwave-assisted reaction. They confirmed that high work function and transparency CuCrO_2 films and improved conductivity with UV–ozone treatment.⁴⁴ In 2017, Qin *et al.* fabricated PSCs based on CuCrO_2

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synthesized by a low temperature novel solution method using acetylacetonate based precursor in rigid as well as flexible substrates and showed energy level depending on composition of copper and chromium confirmed by ultraviolet photoelectron spectroscopy (UPS).⁴⁵

In this study, we report the fabrication of PSCs based on CuCrO₂ and Mg-doped CuCrO₂ nanocrystalline particulate films as HTLs. The fabricated CuCrO₂ based HTLs are p-type semiconductor and used in p-i-n configuration PSCs. The fabricated PSCs showed PCEs of around 13.1% and device performances such as short-circuit current density (J_{sc}) and open-circuit voltage (V_{oc}) were slightly improved when using Mg:CuCrO₂ HTLs.

Experimental

Materials and chemicals

Copper(II) nitrate trihydrate (Cu(NO₃)₂·3H₂O), chromium(III) nitrate nonahydrate (Cr(NO₃)₃·9H₂O), magnesium(II) nitrate hexahydrate (Mg(NO₃)₂·6H₂O), dimethylformamide (DMF, 99.9% purity), dimethyl sulfoxide (DMSO, 99.5% purity), bathocuproine (BCP, 99.99%), HellmanexIII and absolute methanol were purchased from Sigma-Aldrich Co., Ltd (St Louis, MO, USA). Methylammonium iodide (CH₃NH₃I) and phenyl C61 butyric acid methyl ester ([60]PCBM, 99.5% purity) were purchased from Dyesol LTD. (Queanbeyan, Australia) and Nano-C Co., (Massachusetts, USA), respectively. Lead(II) iodide (PbI₂, 99%) was purchased from Tokyo Chemical Industry Co. (TCI, 99.99% purity). Acetone (99.5%), ethanol (99.5%), hydrochloric acid (HCl, 37 wt% aqueous solution) were purchased from DUKSAN Chemicals Co., Ltd (Gyeonggi-do, Korea).

Synthesis of CuCrO₂ and Mg:CuCrO₂ nanocrystals

All chemicals in this study were at analytical grade and used without further purification. CuCrO₂ and Mg:CuCrO₂ nanocrystals were synthesized by using similar method with reported hydrothermal method.^{38,46} 15 mmol of Cu(NO₃)₂·3H₂O, 15 (1 - x) mmol of Cr(NO₃)₃·9H₂O and 15x mmol of Mg(NO₃)₂·6H₂O were dissolved in 70 mL pure deionized water with magnetic stirring bar, follows by 5.0 g NaOH as a mineralizer. The obtained solution was transferred into a 100 mL PPL-lined autoclaves, which was sealed and maintained at 240 °C for 60 h. The precipitate was washed several times with diluted HCl, anhydrous alcohol in sequence and then stored in absolute methanol for further use. Dispersed CuCrO₂ nanocrystals were filtered through a 0.45 μm polytetrafluoroethylene (PTFE) syringe filter, then dried some amount of solution at 70 °C in an oven and concentration was adjusted to 5 mg mL⁻¹.

Fabrication of perovskite solar cells

20 × 20 mm FTO glasses (Fine Chemicals Industry Co., Gyeonggi-do, Korea, 12–14 Ω sq⁻¹) were patterned (etched area: 4 × 20 mm) by wet etching with 4 M HCl. Substrates were rinsed by ultrasonication in detergent (5 wt% of HellmanexIII in deionized (DI) water), deionized water, acetone and ethanol in sequence for 10 min, respectively. After drying in N₂ blow

gas, they were treated in a UV/ozone cleaner for a 10 min. CuCrO₂ layer was deposited by spin coating method at 3000 rpm for 6, 10 and 15 times to control thickness of CuCrO₂ layer, corresponding to 40, 50 and 70 nm, respectively. Mg:CuCrO₂ coated at the same condition for 4 times corresponding thickness to 50 nm. After coating, substrates were transferred onto hot plate at 100 °C for 10 min to dry solvent and into tube furnace for post-annealing treatment at 550 °C under an Ar atmosphere for 1 h to promote networking formation. To prepare the CH₃NH₃PbI₃ solution, CH₃NH₃I and PbI₂ (1 : 1 molar ratio) were dissolved in a mixture of DMF and DMSO (9 : 1 v/v) solvent and then were stirred at room temperature for 12 h to synthesize full dissolved solution (1.45 M) in an inert glove box (H₂O and O₂ < 1 ppm). The perovskite solution was dropped onto the substrate and then coated by spin coating method at 5000 rpm for 25 s, and 0.25 mL of chlorobenzene was dripped onto the film while spinning at 5–6 s. After spinning substrates were transferred to a hot plate at 100 °C and dried for 10 min then cooled down to room temperature. Subsequently, 40 μL of the PCBM solution (20 mg mL⁻¹ in chlorobenzene) was spin coated at 1500 rpm for 25 s and 100 μL of BCP solution (0.5 mg mL⁻¹ in anhydrous ethyl alcohol) was spin coated at 4000 rpm at 20 s. Finally, a 100 nm thick Ag was deposited onto substrate by thermal evaporation with a shadow mask under high vacuum.

Characterizations

The cross-sectional structure of devices was taken by field-emission scanning electron microscopy (FESEM, JSM-7600F, JEOL). Topography and local conductance of CuCrO₂ layers were measured by atomic force microscopy (AFM) and conductive (C-AFM, Nanonavi II, SII Nanotechnology). Morphology and interplanar distance of CuCrO₂ nanocrystals were taken by transmission electron microscopy (TEM, JEM-ARM200F, JEOL). X-ray diffraction (XRD, SmartLab, Rigaku) was used to confirm crystalline structure of nanocrystal. Deposited CuCrO₂ layer was post treated in tube furnace (HTF-Q50, Hantech). Mott–Schottky plots (1/C² vs. E) analysis was produced to measure electronic property of CuCrO₂ in a custom three electrode cell using a potentiostat system (VMP3, Bio-logic science instruments). Ultraviolet photoelectron spectroscopy (UPS, Axis Nova and Ultra DLD, Kratos analytical Ltd) and Kelvin probe force microscopy (KPFM, Nanonavi II, SII Nanotechnology) were used to obtain work function with lock in amplifier. Transmittance and absorption spectra of CuCrO₂ layer were recorded by using a UV/Vis spectrophotometer (OPTIZEN POP, Mecasys). The cross-sectional structure of solar cell and morphology of CuCrO₂ layer were taken by field-emission scanning electron microscopy (FESEM, JSM-7600F, JEOL). J–V curves were measured using a solar simulator (Pec-cell Technologies) with a potentiostat (CHI 608C, CH instruments) under AM 1.5 illumination (100 mW cm⁻²) and calibrated using a reference cell (PV measurements). The illuminated active area was fixed by a metal shadow mask (0.06 cm²) during the measurement. EQE was measured on a quantum efficiency measurement equipment (IQE 200™,

Newport) under monochromatic light illumination from a 300W xenon lamp. PL intensity spectra was recorded with fluorescence lifetime spectrometer (C11367, Hamamatsu Photonics K.K.).

Results and discussion

Fig. 1(a) shows an illustration of crystal structure of CuCrO_2 delafossite compound, indicating closed-packed layered structure of CrO_6 octahedra composed of Cr^{3+} sharing edges with oxygen and monovalent Cu layers. Each layer is linked linearly by “dumb-bell” unit of CuO_2^{3-} , along with the c -axis. Lattice constants in the rhombohedral unit cell are 0.297 and 0.171 nm corresponding to a - and c -axis. The configuration of our inverted planar PSC is shown in Fig. 1(b). CuCrO_2 nanocrystals were coated onto FTO by spin-coating method as particulate films. After the spin coating of absorbing methylammonium lead iodide ($\text{CH}_3\text{NH}_3\text{PbI}_3$) layers, phenyl-C61-butyric acid methyl ester (PCBM) and bathocuproine (BCP) were also spin-coated. Ag electrodes were subsequently deposited by thermal evaporation. PCBM was used as an electron separating and transporting layer, and BCP was used for further complete blocking of holes. It is a complete of PSCs in this study. Energy band alignment in Fig. 1(c) indicates valence level of CuCrO_2 (5.3 eV) is located slightly higher than that of $\text{CH}_3\text{NH}_3\text{PbI}_3$ (5.4 eV) for suitable separation of photo-generated holes in the perovskite layer. Holes generated in perovskite are effectively separated without energy loss due to the well-matched valence band energy level of CuCrO_2 .

Fig. 1 (a) Illustration of crystal structure of delafossite compound (ABX_2 , space group: rhombohedral $R\bar{3}m$). In case of CuCrO_2 , Copper ions are coordinated with the edges of octahedral oxygen ions that are formed with chromium ions ($\text{Cr}(\text{III})\text{O}_6$). Layered structure is organized by monovalent Cu layer and CrO_6 octahedral layer. (b) Cross-sectional image of field emission-scanning electron microscopy (FE-SEM) showing completed PSCs. p-Type CuCrO_2 and PCBM/BCP were used as hole and electron transporting layer, respectively. Each layer of CuCrO_2 , $\text{CH}_3\text{NH}_3\text{PbI}_3$ and PCBM has the thicknesses of 40, 300 and 40 nm. And 100 nm thickness of Ag electrodes were deposited by thermal evaporation. (c) Energy band diagram of FTO/ CuCrO_2 nanoparticulates/ $\text{CH}_3\text{NH}_3\text{PbI}_3$ /PCBM/BCP/Ag with p-i-n configuration showing valence and conduction band level alignment for the PSCs.

Fig. 2 (a) TEM image of as-prepared CuCrO_2 nanocrystals. Nanoplates and/or nanorods of the crystal can be observed and selected area electron diffraction pattern (SAED) as inset. (b) High-resolution TEM (HRTEM) image indicating interplanar distance about 0.56 nm corresponding to (003) plane of delafossite CuCrO_2 . (c) XRD patterns of CuCrO_2 and $\text{Mg}:\text{CuCrO}_2$ as-prepared nanocrystals showing crystallization into the identical delafossite structure. (d) Planar-view SEM image of CuCrO_2 layer deposited onto FTO.

Fig. 2a and b are Transmission Electron Microscopy (TEM) images showing morphology and interplanar distance of individual CuCrO_2 nanocrystals. The synthesized nanocrystals exhibit two forms of shape; one is as nanoplates with the average diameter of $\sim 20 \text{ nm}$ and another as nanorods with the average size of $7 \times 17 \text{ nm}$, respectively. SAED pattern in inset shows delafossite crystalline phase of CuCrO_2 nanocrystals. In addition, the interplanar distance of 0.56 nm corresponds to the

Fig. 3 Surface morphology and leakage current map of bare FTO ((a) and (b)). Surface morphologies ((c), (e), and (g)) and leakage current maps ((d), (f), and (h)) of the CuCrO_2 nanoparticulate films with the thickness of 30, 40, and 70 nm, respectively. The leakage current is clearly observed through the nanoparticulate films with the thickness of 30 and 40 nm as shown in Fig. 3(d) and (f). It is noted that the appreciable reduction in the leakage current in Fig. 3(h) indicating the complete coverage with the thickness of 70 nm. The surface roughness in RMS is about 16, 7.7, 6.9 and 9.2 nm for (a), (c), (e), and (g). All samples are measured in constant mode (force ref.: -0.5 nN , scan speed: 0.5 Hz , applied bias: 0.5 V).

lattice spacing of 0.57 nm which between Cu–Cu ions originated from *c*-axis ((003) plane) of CuCrO₂ delafossite structure.³⁸ Fig. 2(c) shows XRD patterns one from as-prepared CuCrO₂ and the other is from Mg doped CuCrO₂. The XRD patterns are almost identical. Temperature and oxygen partial pressure during post-annealing process are critical to form pure CuCrO₂ phase. Synthesized CuCrO₂ nanocrystals are stable during low temperature annealing in air, however, it would be decomposed to secondary phases, *i.e.*, CuO and CuCr₂O₄, in high temperature annealing. On the other hand, phase decomposition did not happen when high temperature annealing in Ar and the crystal growth has been observed.^{38,44} After synthesizing nanocrystals by the hydrothermal method, dispersing experiments were performed with different solvents⁴⁴ as shown in Fig. S1.† Gradual aggregations of nanocrystals were observed in some solvents. After 30 hours, nanocrystals were well dispersed only in methanol. With methanol based dispersing solution, CuCrO₂ layers were deposited onto FTO by spin-coating. Thickness of CuCrO₂ layers was controlled by adjusting the number of coating. When spin-coated for 4, 10 and 15 times, the thickness of layers were achieved as 40, 50 and 70 nm, respectively. Fig. 2(d) shows planar-view SEM image of CuCrO₂ nanocrystals deposited onto FTO. After the deposition of nanocrystals, post

annealing treatments at 550 °C for 1 hour in Ar were performed to form solid networks between the nanocrystals.

Fig. 3 shows surface morphologies and their leakage current maps of the CuCrO₂ nanoparticulate films obtained by atomic force microscopy (AFM) and conducting mode of AFM. Surface morphologies (Fig. 3(c), (e), and (g)) and leakage current maps (Fig. 3(d), (f), and (h)) of the CuCrO₂ nanoparticulate films with the thickness of 30, 40, and 70 nm, were shown. The leakage current is clearly observed through the nanoparticulate films with the thickness of 30 and 40 nm as shown in Fig. 3(d) and (f). It is noted that the appreciable reduction in the leakage current in Fig. 3(h) indicating the complete coverage with the thickness of 70 nm.

Fig. 4(a) shows Mott–Schottky measurement of CuCrO₂ nanoparticulate films, and p-type semiconducting behaviour was confirmed by negative slope at a wide range of frequency from 1000 to 3000 Hz. The flat band potential of CuCrO₂ was obtained by fitting from the measurement results with a value of 0.50 V *versus* standard calomel reference electrode (SCE) and of donor density with $4.28 \times 10^{19} \text{ cm}^{-3}$. We also further investigated the films by ultraviolet photoelectron spectroscopy (UPS) and Kelvin Probe Force Microscopy (KPFM) to obtain the information of electronic band structure with the work function. Fig. 4(b) shows the value of E_F and E_{cutoff} located at 0.96 and 16.96 eV, and the work function of CuCrO₂ is estimated to be 5.26 eV, and those of Mg:CuCrO₂ is estimated 5.46 eV as shown in Fig. S2.† Fig. 4(c) shows the work function of CuCrO₂ measured by KPFM with a value of 5.28 eV, which showed

Fig. 4 (a) Electrochemical Mott–Schottky plot of CuCrO₂ particulate layers (post-annealed in Ar at 550 °C for 1 h) with frequency of 1, 2 and 3 kHz in the electrolyte of 0.5 M KOH with a standard calomel electrode, indicating a p-type characteristic. (b) Ultraviolet photoelectron spectroscopy (UPS) spectra of cutoff position ($E_{\text{cutoff}} = 16.92 \text{ eV}$) of binding energy and position of kinetic energy of the electron ($E_F = 0.96 \text{ eV}$) in inset, using He(I) source (21.22 eV). The measured work function of CuCrO₂ layer on FTO was 5.26 eV (vs. vacuum level). (c) Work function of the CuCrO₂ nanocrystal particulate films measured by Kelvin probe force microscopy (KPFM) calibrated the cantilever with the surface of highly oriented pyrolytic graphite (HOPG). Each curve showing straight lines was measured by taking 25 randomly selected points on the nanocrystal particulate films and HOPG, work function was estimated to be 5.26 eV. (d) Optical transmittance spectra of air-baseline FTO and FTO/CuCrO₂ layer with each thickness showing highly transparent at wide wavelength above 400 nm. Black line indicates a transmittance of FTO on to glass and blue, purple and red correspond with CuCrO₂ layers of 6, 10 and 15 times of coating, respectively. The inset shows Tauc plot of absorption coefficient (α^2) vs. photon energy ($h\nu$) to determine the band gap (E_g) indicating a value of direct optical bandgap of around 3.36 eV.

Fig. 5 (a) *J*–*V* curves of perovskite solar cells based on different thicknesses of CuCrO₂ layers measured under 1.5 AM illumination (100 mW cm^{−2}). Each color of blue, purple and red corresponds to the thicknesses of CuCrO₂ layers of about 40, 50 and 70 nm, respectively. The close and open symbols indicate *J*–*V* curves under reverse and forward bias, respectively. (b) IPCE spectra and integrated current density of devices. The open symbols of square and triangle indicate the calculated integrated current density. EQE and integrated *J*_{sc} of device based on thinner CuCrO₂ layer increases to shorter wavelength (300–500 nm). (c) *J*–*V* characteristics of champion cells with different HTL materials. Each color of red, purple and blue indicates optimized CuCrO₂, Mg:CuCrO₂ and PEDOT:PSS based devices under reverse bias. (d) Photoluminescence spectra of devices based on different HTL materials that deposited on glass/FTO substrate with excitation at 464 nm. Each symbols (color) of diamond (black), circle (red), triangle (purple) and square (blue) indicate that without HTL, CuCrO₂, Mg:CuCrO₂ and PEDOT:PSS, respectively.

a good agreement with the result of UPS, indicating appropriate alignment with the valence band energy level of $\text{CH}_3\text{NH}_3\text{PbI}_3$ (5.4 eV) and effective separation of photo-generated holes. Fig. 4(d) shows the optical transmittance spectra of CuCrO_2 deposited on FTO with different thicknesses of ~ 40 , 50 and 70 nm, respectively, by using UV-Vis spectroscopy. Thin CuCrO_2 layers having highly transparent property of 90% or more in visible light range are desirable to HTL, not absorbing the light reaching the perovskite photo-absorber. High transmittance is due to the large optical bandgap of CuCrO_2 was calculated based on Tauc plot of the Kubelka–Munk transformation from the absorption spectra. The plot of α^2 vs. $h\nu$ in the inset and shows the direct optical bandgap of 3.36 eV, and that was measured to be 3.33 eV in case of Mg:CuCrO_2 as shown in Fig. S3,[†] reasonably matched to values in the literature.³⁹

With the delafossite CuCrO_2 particulate HTLs, we fabricated PCs. The resultant of current density (J) measured with respect to the applied voltage (V) under 1.5 AM illumination is shown in Fig. 5(a) and detailed parameters are listed in Table 1. To adjust thickness of CuCrO_2 layers, we control the number of coating times 6, 10 and 15, corresponding to around 40, 50 and 70 nm in thickness, respectively. With the increase of CuCrO_2 layer thicknesses, all the parameters (J_{sc} , V_{oc} , and FF) PCE are decreased. The PCs based on the 40 nm thick CuCrO_2 HTL show the best performance in this study. The best PCE was $\sim 13.1\%$. We also measured the J – V curves using reverse as well as forward scans. In forward scan direction, slightly improved PCE with increased FF, despite a low degree of decreased in J_{sc} and V_{oc} . Unlike the planar – type of inverted PCs, all of our PCs show appreciable hysteresis. It is simply because of high resistant CuCrO_2 nanocrystals were used as HTLs. The incident photon to electron conversion efficiency (IPCE) spectrum (Fig. 5(b)) of PCs based on CuCrO_2 HTLs with different thicknesses exhibits an acceptable response in broad wavelength range from 400 to 750 nm. Decreased EQE spectra in relatively thick CuCrO_2 layers are shown, resulting from reduced transmittance of light. In addition, integrated currents of IPCE over the full spectrum are calculated to be 17.5, 17.0 and 16.0 mA

cm^{-2} , respectively, which are well match with those obtained from the J – V curves. J – V curves of the fabricated PCs based on different HTLs using CuCrO_2 , Mg:CuCrO_2 and PEDOT:PSS as in inverted structure were measured shown in Fig. 5(c) and summarized in Table 2 with the champion performance of the cells. Devices based on CuCrO_2 show relatively higher V_{oc} than the devices on PEDOT:PSS , which verified more suitable alignment to valence energy level of $\text{CH}_3\text{NH}_3\text{PbI}_3$ (5.4 eV) than PEDOT:PSS (5.2 eV).⁴⁷ In addition, V_{oc} of devices based on Mg:CuCrO_2 was higher than that of CuCrO_2 , which related to deeper work function property resulted from UPS measurement data. Hole transporting materials with higher work-function, despite of the same device configuration and similar charge transporting property, exhibit higher V_{oc} due to lower charge recombination rate.⁴⁸ Steady-state photoluminescence (PL) spectra were measured to investigate effects on extracting photo-generated carriers from perovskite absorber when using different HTL. The PL measurement with the PCs based on PEDOT:PSS is also carried out as a reference. CuCrO_2 and Mg:CuCrO_2 can effectively quench in the PL of $\text{CH}_3\text{NH}_3\text{PbI}_3$ similar level to that of PEDOT:PSS , resulting in demonstrating that CuCrO_2 can function as HTL material and have an advantage of replacing organic PEDOT:PSS .

In delafossite materials, Cu–Cu distance would be an important role of conductivity because holes are expected to hope from Cu to Cu along 3d-orbital and Cu–Cu distance is determined by M^{III} atoms. When divalent Mg is doped in CuCrO_2 , the dopants were located on trivalent Cr lattice site forming Mg_{Cr} defect thermodynamically with lower formation energy, which are investigated by density functional theory.⁴³ Thus Cu–Cu distance is decreased by Mg dopant, as ionic radius of Mg is smaller than that of Cr, leading to overlap of Cu d-orbital and resulting increase of charge mobility and conductivity.⁴⁰ Ultimately, we speculated about the reason for slightly improved current density of PCs based on Mg:CuCrO_2 .

Not only high photovoltaic performances, also air stability that is resistant to external environment is vital to practical application of PCs. PCs based on different HTLs were tested without any encapsulation in an ambient (at 26 °C and with 46–49% relative humidity in dark condition). The PCE of CuCrO_2 and Mg:CuCrO_2 based solar cell maintains above 80% of the initial value after 216 h of storage, on the other hand PCE of PEDOT:PSS based device decreased to < 60% of its initial value after 120 h of storage as shown in Fig. 6(a). A main reason of decreasing PCE is reduced FF (Fig. 6(d)) and V_{oc} (Fig. 6(c)) before 168 h of storage times, in addition, J_{sc} of PEDOT:PSS based PCs which was kept constant was abruptly decreased after 168 h,

Table 1 Photovoltaic parameters of the PCs as different hole transporting materials as CuCrO_2 , Mg:CuCrO_2 and PEDOT:PSS

HTL	J_{sc} (mA cm^{-2})	V_{oc} (V)	FF (%)	PCE (%)
CuCrO_2	18.0	0.97	75.1	13.1
Mg:CuCrO_2	18.4	1.00	71.3	13.1
PEDOT:PSS	20.0	0.91	81.0	14.8

Table 2 Photovoltaic parameters of the CuCrO_2 based PCs as a function of thickness of CuCrO_2 layer

Thickness of HTL	Scan direction	J_{sc} (mA cm^{-2})	V_{oc} (V)	FF (%)	PCE (%)
6c (40 nm)	Reverse	18.0	0.97	75.1	13.1
	Forward	17.9	0.96	78.5	13.4
10c (50 nm)	Reverse	17.0	0.95	73.4	11.9
	Forward	16.9	0.91	78.2	12.0
15c (70 nm)	Reverse	15.8	0.95	73.5	11.0
	Forward	16.2	0.91	77.3	11.4

Fig. 6 Stability of PSCs based on CuCrO_2 , Mg:CuCrO_2 , PEDOT:PSS without any encapsulation. Each symbol (color) of circle (red), triangle (purple) and square (blue) indicate that CuCrO_2 , Mg:CuCrO_2 and PEDOT:PSS, respectively. 4–Main parameters of PCE (a), J_{sc} (b), V_{oc} (c) and FF (d) were measured as a function of storage time (hours) in ambient atmosphere at 26 °C, 48% R.H. condition.

unlike CuCrO_2 based PSCs shown in Fig. 6(b), and accordingly the PCE after 168 h was reduced. Decreased PCE occurred due to acidic and hygroscopic nature of PEDOT:PSS,^{24,49} since $\text{CH}_3\text{-NH}_3\text{PbI}_3$ is easily decomposed by humidity and react with acidic PEDOT:PSS^{50,51} and it was observed that it was decomposed into PbI_2 which turned to yellow colour. The results show that CuCrO_2 is suitable materials for HTL and makes the PSCs stable for external environment.

Conclusions

We synthesized Cu based delafossite materials (CuCrO_2 and Mg:CuCrO_2) which have preferred crystal structure with p-type wide bandgap transparent conducting oxide (TCO) and they were applied as a HTL in p–i–n PSCs with FTO/ CuCrO_2 (- Mg:CuCrO_2) layer/ $\text{CH}_3\text{NH}_3\text{PbI}_3$ /PCBM/BCP/Ag configuration. CuCrO_2 nanocrystals were synthesized by hydrothermal method have appropriate characteristic as a HTL in PSCs due to high optical transparency in broad wavelength of light and electrically well aligned valence band energy level to $\text{CH}_3\text{NH}_3\text{PbI}_3$. In addition, inorganic material is more stable against external condition compared to conventional organic HTL (PEDOT:PSS). However, it is challenging to form thin, dense and uniform particulate layer by spin-coating, simply because of nanocrystal size and aggregation. To improve device performance, research on forming dense and uniform layer by synthesizing ultra-small sized nanocrystals and various coating method would be more desirable. Performance of devices was slightly improved by doping Mg, even though post annealing to form networking between nanocrystals was not processed, implying that it is applicable to flexible devices that cannot be subjected to high temperature heat treatment. As a result, CuCrO_2 exhibit appropriate hole transporting materials with PCE of 13.1% and can be promising candidate for flexible devices.

Conflicts of interest

There are no conflicts to declare.

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